

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HEIDE ET AL.	
		Examiner Karl E Group	Art Unit 1755	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0019385	01-2004	Ayers et al.	623/23.5
	B	US-2003/0049328	03-2003	Dalal et al.	424/602
	C	US-2003/0171822	09-2003	Lo, Wei Jen	623/23.56
	D	US-4,195,366	04-1980	Jarcho et al.	623/23.56
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	1-108143	04-1989	Japan	Olympus	-/-
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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